

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re **NEW DIVISIONAL** Application)
Yasuhiko TAKEMURA et al.) Art Unit: 2822
Based on U.S. Serial No. 09/311,067) Examiner: M. Prenty
Which was Filed: May 31, 1999)
For: SEMICONDUCTOR DEVICE AND METHOD FOR) Date: December 28, 2001
MANUFACTURING THE SAME)



CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on 2001.

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents

Washington, D.C. 20231

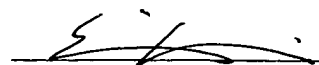
Sir:

In accordance with the provisions of 37 C.F.R. 1.56 and 37 C.F.R. 1.97-1.99, it is requested that the reference(s) listed on the attached Form PTO-1449 be made of record in the above-identified application. Copies of the references are submitted herewith in accordance with 37 C.F.R. 1.98(a).

The enclosed listed references were cited in family application Serial Nos. 08/313,910, 08/966,975 and 09/311,067.

The Commissioner is hereby authorized to charge fees under 37 C.F.R. §§1.16, 1.17, 1.20(a), 1.20(b), 1.20(c), and 1.20(d) (except the Issue Fee) which may be required now or hereafter, or credit any overpayment to Deposit Account No. 19-2380.

Respectfully submitted,


Eric J. Robinson
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Form PTO-1449
(Rev. 8-83)U.S. Department of Commerce
Patent and Trademark Office

Atty Docket 0756-2413

Serial No.

INFORMATION DISCLOSURE STATEMENT

Applicants: Yasuhiko TAKEMURA et al.

Filing Date: December 28, 2001

Group Art Unit:
Unassigned

JCS55 U.S. PTO
10/028269
12/28/01

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date (if appropriate)
	3,597,667	08/03/1971	Horn.F			
	4,313,782	02/02/1982	Sokoloski.J			
	4,447,272	05/08/1984	Saks.N			
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	5,719,065	02/17/1998	Takemura.Y et al.			
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Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	02-159730	06/19/1990	JP			Full Eng	
	03-280420	12/11/1991	JP			Full Eng	
	04-180219	06/26/1992	JP			Eng Abst	
	04-299566	05/18/1993	JP			Eng Abst	
	05-055581	03/05/1993	JP			Full Eng	
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	05-082442	04/02/1993	JP			Full Eng	
	05-226364	09/03/1993	JP			Eng Abst	

Examiner

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*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

12/27/2001

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FOREIGN PATENT DOCUMENTS

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						Yes	No
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	05-259458	10/08/1993	JP			Eng Abst	
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	Shimoyama et al., "Increased Hot-Carrier Degradation Due to Water in TEOS/O3-Oxide", pp. 723, 1992, Extended Abstracts (The 39th Spring Meeting, 1992); The Japan Society of Applied Physics and Related Societies, No. 2, 30p-ZM-3, (English Abstract only)
	Shimoyama et al., "Increased Hot-Carrier Degradation Due to Water in TEOS/O3-Oxide(2) - Water Blocking Effect of an ECR-SiO2 Film Under TEOS/O3-Oxide and Improvement of Hot-Carrier Tolerance", pp. 723, 1992, Extended Abstracts (The 39th Spring Meeting); The Japan Society of Applied Physics and Related Societies, No. 2, 30p-ZM-4, (English Abstract)

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